# NAND Flash Code Information(1/3)

Last Updated: August 2009

# 

1. Memory (K)

2. NAND Flash: 9

3. Small Classification

(SLC: Single Level Cell, MLC: Multi Level Cell,

SM: SmartMedia, S/B: Small Block)

1: SLC 1 Chip XD Card

2: SLC 2 Chip XD Card

3: 4bit MLC Mono

4: SLC 4 Chip XD Card

5: MLC 1 Chip XD Card

6: MLC 2 Chip XD Card

7: SLC moviNAND

8: MLC moviNAND

9:4bit MLC ODP

A: 3bit MLC MONO

B: 3bit MLC DDP

C: 3bit MLC QDP

F: SLC Normal

G: MLC Normal

H: MLC QDP

K: SLC Die Stack

L: MLC DDP

M: MLC DSP

N: SLC DSP

O: 3bit MLC ODP

P: MLC ODP

Q: SLC ODP

R: MLC 12-die stack

S: MLC 6 Die Stack

T: SLC SINGLE (S/B)

U: MLC 16 Die Stack

W: SLC 4 Die Stack

#### 4~5. Density

12 : 512M	16:16M	28 : 128M
32 : 32M	40 : 4M	56 : 256M
64 : 64M	80 : 8M	1G : 1G
2G : 2G	4G : 4G	8G : 8G
AG : 16G	BG: 32G	CG: 64G
DG : 128G	EG: 256G	FG: 256G
GG : 384G	HG: 512G	LG : 24G
NG: 96G	ZG : 48G	00 : NONE

#### 6. Technology

0 : Normal (x8) 1 : Normal (x16)

C : Catridge SIP D : DDR

Z:SSD

#### 7. Organization

0: NONE 8: x8

6:x16

#### 8. Vcc

A: 1.65V~3.6V B: 2.7V (2.5V~2.9V) C: 5.0V (4.5V~5.5V) D: 2.65V (2.4V ~ 2.9V) E: 2.3V~3.6V R: 1.8V (1.65V~1.95V)

Q: 1.8V (1.7V ~ 1.95V) T: 2.4V~3.0V S: 3.3V (3V~3.6V/ VccQ1.8V (1.65V~1.95V) U: 2.7V~3.6V V: 3.3V (3.0V~3.6V)

W: 2.7V~5.5V, 3.0V~5.5V 0: NONE

#### 9. Mode

0: Normal

1 : Dual nCE & Dual R/nB

3: Tri /CE & Tri R/B

4: Quad nCE & Single R/nB

5: Quad nCE & Quad R/nB

6:6 nCE & 2 RnB

7:8 nCE & 4 RnB

8:8 nCE & 2 RnB

9: 1st block OTP

A: Mask Option 1

L: Low grade

#### 10. Generation

M: 1st Generation

A: 2nd Generation

B: 3rd Generation

C: 4th Generation

D: 5th Generation

E: 6th Generation

Y : 25th Generation

Z: 26th Generation



# NAND Flash Code Information(2/3)

Last Updated: August 2009

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11. "--"

#### 12. Package

8: TSOP1 (Lead-Free, Halogen-Free, CU)

9:56TSOP1 (Lead-Free, Halogen-Free, CU)

A: COB

B: FBGA (Halogen-Free, Lead-Free)

D: 63-TBGA

E: ISM (Lead-Free, Halogen-Free)

F: WSOP (Lead-Free) G: FBGA

H: BGA (Lead-Free, Halogen-Free)

I: ULGA (Lead-Free) (12\*17)

J: FBGA (Lead-Free)

K: ULGA (Lead-Free, Halogen-Free) (12\*17)

L: ULGA (Lead-Free, Halogen-Free) (14\*18)

M: 52-ULGA (Lead-Free, Halogen-Free) (13\*18)

P: TSOP1 (Lead-Free)

Q: TSOP2 (Lead-Free)

R: 56-TSOP1 (Lead-Free, Halogen-Free)

S: TSOP1 (Lead-Free, Halogen-Free)

T: WSOP (Lead-Free, Halogen-Free)

U: COB (MMC)

V: WSOP W: Wafer

Y: TSOP1 Z: WELP (Lead-Free)

#### 13. Temp

C : Commercial I : Industrial

S: SmartMedia

B: SmartMedia BLUE

0 : NONE (Containing Wafer, CHIP, BIZ, Exception handling code)

#### 14. Customer Bad Block

B: Include Bad Block

D: Daisychain Sample

K: Special Handling

L: 1~5 Bad Block

N: ini. 0 blk, add. 10 blk

S: All Good Block

0 : NONE (Containing Wafer, CHIP, BIZ, Exception handling code)

#### 15. Pre-Program Version

0: None

Serial (1~9, A~Z)



# NAND Flash Code Information(3/3)

Last Updated: August 2009

#### 16. Packing Type

- Common to all products, except of Mask ROM
- Divided into TAPE & REEL(In Mask ROM, divided into TRAY, AMMO Packing Separately)

Divide	Packing Type	New Marking				
5555555555	TAPE & REEL	Т				
Component	Other ( Tray, Tube, Jar )	0 ( Number)				
	Stack	S				
Module	MODULE TAPE & REEL	Р				
wodule	MODULE Other Packing	М				

17~18. Customer "Customer List Reference"



# 三星 flash 命名规则

如何根据 Samsung 的 Nand Flash 的芯片型号(Part Number)读懂芯片详细信息 + 举例 K9GAG08U0M 说明

[Samsung: NAND Flash Code Information]

三星的 NAND Flash Code Information:

http://www.samsung.com/global/business/semiconductor/productInfo.do?fmly\_id=672&partnum=K9GAG08U0M

中的 Mart Number Decoder

拷贝出来如下:

NAND Flash Code Information

- 1. Memory (K)
- 2. NAND Flash: 9
- 3. Small Classification

(SLC : Single Level Cell, MLC : Multi Level Cell,

SM : SmartMedia, S/B : Small Block)

1 : SLC 1 Chip XD Card

2 : SLC 2 Chip XD Card

3 : 4bit MLC Mono

4 : SLC 4 Chip XD Card

5 : MLC 1 Chip XD Card

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8 : MLC moviNAND

9 : 4bit MLC ODP

A : 3bit MLC MONO

B : 3bit MLC DDP

C: 3bit MLC QDP

C . SDIC MLC QD

F : SLC Normal

G : MLC Normal

H: MLC QDP

K : SLC Die Stack

L: MLC DDP

M : MLC DSP

N: SLC DSP

O: 3bit MLC ODP

P: MLC ODP

Q : SLC ODP

R: MLC 12-die stack S: MLC 6 Die Stack T : SLC SINGLE (S/B) U: MLC 16 Die Stack W: SLC 4 Die Stack 4~5. Density (注:实际单位应该是 bit,而不是 Byte) 12 : 512M 16 : 16M 28 : 128M 32 : 32M 40 : 4M 56 : 256M 64 : 64M 80 : 8M 1G : 1G 2G : 2G 4G : 4G 8G : 8G AG : 16G BG : 32G CG : 64G DG : 128G EG : 256G FG : 256G GG: 384G HG: 512G LG: 24G NG: 96G ZG: 48G 00: NONE 6. Technology 0 : Normal (x8) 1 : Normal (x16) C : Catridge SIP D : DDR M : moviNAND N : moviNAND FAB P: moviMCP T: Premium eSSD Z : SSD7. Organization 0 : NONE 8 : x8 6: x168. Vcc A :  $1.65V^{\sim}3.6V B$  :  $2.7V (2.5V^{\sim}2.9V)$ C: 5. 0V  $(4.5V^{5}.5V)$  D: 2. 65V  $(2.4V^{2}.9V)$ E:  $2.3V^3$ . 6V R: 1.8V ( $1.65V^1$ . 95V) Q : 1.8V (1.7V  $^{\sim}$  1.95V) T : 2.4V $^{\sim}$ 3.0V  $S : 3.3V (3V^3.6V / VccQ1.8V (1.65V^1.95V)$  $U : 2.7V^{3}.6V V : 3.3V (3.0V^{3}.6V)$ W:  $2.7V^{\sim}5.5V$ ,  $3.0V^{\sim}5.5V$  0: NONE 9. Mode 0 : Normal 1 : Dual nCE & Dual R/nB 3 : Tri /CE & Tri R/B 4 : Quad nCE & Single R/nB 5 : Quad nCE & Quad R/nB 6 : 6 nCE & 2 RnB 7 : 8 nCE & 4 RnB 8 : 8 nCE & 2 RnB 9: 1st block OTP A: Mask Option 1 L: Low grade 10. Generation

M : 1st Generation A : 2nd Generation

- B: 3rd Generation C: 4th Generation D: 5th Generation E: 6th Generation Y: 25th Generation Z: 26th Generation 11. "—" 12. Package 8 : TSOP1 (Lead-Free, Halogen-Free, CU) 9: 56TSOP1 (Lead-Free, Halogen-Free, CU) A : COB B: FBGA (Halogen-Free, Lead-Free) D: 63-TBGA E: ISM (Lead-Free, Halogen-Free) F: WSOP (Lead-Free) G: FBGA H: BGA (Lead-Free, Halogen-Free) I: ULGA (Lead-Free) (12\*17) J : FBGA (Lead-Free) K: ULGA (Lead-Free, Halogen-Free) (12\*17) L: ULGA (Lead-Free, Halogen-Free) (14\*18) M: 52-ULGA (Lead-Free, Halogen-Free) (13\*18) P: TSOP1 (Lead-Free) Q : TSOP2 (Lead-Free) R: 56-TSOP1 (Lead-Free, Halogen-Free) S: TSOP1 (Lead-Free, Halogen-Free) T: WSOP (Lead-Free, Halogen-Free) U : COB (MMC) V : WSOP W : Wafer Y: TSOP1 Z: WELP (Lead-Free) 13. Temp C : Commercial I : Industrial S: SmartMedia B : SmartMedia BLUE 0 : NONE (Containing Wafer, CHIP, BIZ, Exception handling code) NAND Flash Code Information (2/3) K 9 X X X X X X X X - X X X X X X X 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 14. Customer Bad Block B: Include Bad Block D : Daisychain Sample K : Special Handling L: 1~5 Bad Block
- N: ini. 0 blk, add. 10 blk
- S: All Good Block
- 0 : NONE (Containing Wafer, CHIP, BIZ, Exception

handling code)

## 15. Pre-Program Version

0 : None

Serial  $(1^{\circ}9, A^{\circ}Z)$ 

#### 16. Packing Type

- Common to all products, except of Mask ROM
- Divided into TAPE & REEL(In Mask ROM, divided into TRAY, AMMO Packing Separately

Divide	Packing Type	New Marking				
	TAPE & REEL	T				
Component	Other ( Tray, Tube, Jar )	0 ( Number)				
	Stack	S				
Component	TRAY	Υ				
Mask ROM)	AMMO PACKING	A				
	MODULE TAPE & REEL	P				
Module	MODULE Other Packing	M				

# 17~18. Customer "Customer List Reference"

### 【举例说明】

- 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1																	
K	9	G	Α	G	0	8	U	0	M	-	P	C	В	0			
1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18

## K9GAG08U0M 详细信息如下:

1. Memory (K)

2. NAND Flash: 9

3. Small Classification

(SLC : Single Level Cell, MLC : Multi Level Cell,

SM : SmartMedia, S/B : Small Block)

G: MLC Normal

4<sup>5</sup>. Density

AG: 16G (Note: 这里单位是 bit 而不是 byte, 因此实际大小是 16Gb=2GB)

6. Technology

0 : Normal (x8)

7. Organization

0 : NONE 8 : x8

8. Vcc

 $U: 2.7V^{3}.6V$ 

9. Mode

0 : Normal

10. Generation

M : 1st Generation

11. **"—"** 

12. Package

P: TSOP1 (Lead-Free)

13. Temp

C : Commercial

## zhangshengheng@126.com

14. Customer Bad Block

B : Include Bad Block

15. Pre-Program Version

0 : None

整体描述就是:

K9GAG08U0M 是,三星的 MLC Nand Flash,工作电压为 2.7V~3.6V,x8(即 I/0 是 8 位),大小是 2GB(16Gb),TSOP1 封装。

# Hynix 海力士

- H 2 7 X X X X X X X X X X X X X
- <del>(1) HY</del>NIX
- (2) PRODUCT FAMILY
- (4) POWER SUPPLY (VCC)
- (8) NAND CLASSIFICATION
- (7) ORGANIZATION
- (14) BAD BLOCK
- (11) PACKAGE TYPE
- 2 : Flash
- S: SLC + Single Die + Small Block
- A: SLC + Double Die + Small Block
- B: SLC + Quadruple Die + Small Block
- F: SLC + Single Die + Large Block
- G: SLC + Double Die + Large Block
- H: SLC + Quadruple Die + Large Block
- J: SLC + ODP + Large Block
- K: SLC + DSP + Large Block
- T: MLC + Single Die + Large Block
- U: MLC + Double Die + Large Block
- V: MLC + Quadruple Die + Large Block
- W: MLC + DSP + Large Block
- Y: MLC + ODP + Large Block
- C: Included Bad Block
- E: 1~5 Bad Block Included
- M: All Good Block
- I: TSOP1
- B: WSOP
- S: USOP
- P: LSOP1
- T: FBGA
- V: LGA
- S: WLGA
- N: VLGA
- F: ULGA
- X: Wafer
- M: PGD1 (chip)
- Y: KGD
- U: PGD2
- W: 1st
- C: 2nd
- K: 3rd
- D: 4th

```
M
A
B
C
(5), (6) DENSITY
1: 1 nCE & 1 R/nB; Sequential Row Read Enable
2: 1 nCE & 1 R/nB; Sequential Row Read Disable
4: 2 nCE & 2 R/nB; Sequential Row Read Enable
5: 2 nCE & 2 R/nB; Sequential Row Read Disable
D: Dual Interface; Sequential Row Read Disable
F: 4 nCE & 4 R/nB; Sequential Row Read Disable
```

# micron镁光nand命名规则

### www.micron.com/support/designsupport/documents/png

Standard NAND Flash Part Numbering System
Micron's part numbering system is available at
Standard NAND Flash\*

# MT **2**9F 2G 08 A A A WP - xx xx xx xx ES : A

Micron Technology Design Revision (shrink)

A = 1st design revision

# 1. Single-Supply Flash

29F = Single-Supply NAND Flash Production Status

29H = High Speed NAND Blank = Production

ES = Engineering samples

# 2. Density QS = Qualification samples

1G = 1Gb MS = Mechanical samples

2G = 2Gb

4G = 4Gb Operating Temperature Range

8G = 8Gb Blank = Commercial  $(0^{\circ} \text{ C to } +70^{\circ} \text{ C})$ 

16G = 16Gb ET = Extended (-40° C to +85° C)

 $32G = 32Gb \text{ WT} = \text{Wireless } (-25^{\circ} \text{ C to } +85^{\circ} \text{ C})$ 

64G = 64Gb

128G = 128Gb Block Option (Reserved for use)

256G = 256Gb Blank = Standard device

# 3. Device Width Flash Performance

08 = 8 bits Blank = Full specification

16 = 16 bits

# 4. Speed Grade (MT29H Only)

Classification 15 = 133 MT/s

 $12 = 166 \, \text{MT/s}$ 

# 5. Mark Bit/cell Die RnB

A SLC 1 1 Package Code

B SLC 2 1 WP = 48-pin TSOP I (CPL version) (Pb-free)

C SLC 2 1 WC = 48-pin TSOP I (OCPL version) (Pb-free)

D SLC 2 2 H1 = 100-ball VFBGA (Pb-free), 12 x 18 x 1.0

E SLC 2 2 H2 = 100-ball TFBGA (Pb-free), 12 x 18 x 1.2

F SLC 4 2 HC = 63-ball VFBGA,  $10.5 \times 13 \times 1.0$ 

G SLC 4 2 C2 = 52-pad ULGA,  $12 \times 17 \times 0.4$  (use TBD)

J SLC 4 + 4 2 + 2 C3 = 52-pad ULGA, 12 x 17 x 0.65

K SLC 8 4 C4 = 52-pad VLGA, 12 x 17 x 1.0 (SDP/DDP/QDP)

Z SLC 1 NA C5 = 52-pad VLGA,  $14 \times 18 \times 1.0$  (SDP/DDP/QDP)

C6 = 52-pad LLGA, 14 x 18 x 1.47 (8DP, QDP, DDP)

M MLC 1 1 C7 = 48-pad LLGA, 12 x 20 x 1.47 (8DP)

N MLC 2 1 SWC = 48-pin Stacked TSOP (OCPL version) (Pb-free)

- P MLC 2 1 SWP = 48-pin Stacked TSOP (CPL version) (Pb-free)
- Q MLC 2 2
- R MLC 2 2 Generation (M29 only)/Feature Set
- T MLC 4 2 A = 1st set of device features
- U MLC 4 2 B = 2nd set of device features (rev only if different than 1st set)
- W MLC 8 4 D = 4th set of device features (rev only if different)
- Y MLC 8 4 etc.

# 6. Operating Voltage Range

- A = 3.3V (2.70 3.60V), VccQ 3.3V (2.70 3.60V)
- B = 1.8V (1.70 1.95V)
- C = 3.3V (2.70 3.60V), VccQ 1.8V (1.70 1.95V)

\*Contact Micron for help differentiating between standard and next-generation NAND offerings.

## intel nand code name

## Figure 52. Decoder



